

<b>Notice of References Cited</b>	Application/Control No. 10/756,776	Applicant(s)/Patent Under Reexamination TANAKA, KOICHIRO	
	Examiner Phillip Nguyen	Art Unit 2828	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,229,569 A	07-1993	Miyauchi et al.	219/121.6
*	B	US-5,963,364 A	10-1999	Leong et al.	359/352
*	C	US-6,066,516 A	05-2000	Miyasaka, Mitsutoshi	438/149
*	D	US-5,231,641 A	07-1993	Ortiz, Mark V.	372/21
*	E	US-5,959,779 A	09-1999	Yamazaki et al.	359/624
*	F	US-5,005,969	04-1991	Kataoka, Keiji	353/122
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.